IN THE CLAIMS:

Please amend the claims as follows:

Claim 1 (Original): A laser processing apparatus for irradiating a wafer-like object to be

processed with first laser light while locating a light-converging point within the object so as to

form a modified region by multiphoton absorption within the object, the apparatus comprising:

a condenser lens for converging the first laser light and second laser light for measuring a

displacement of a laser light irradiation surface of the object onto the object on the same axis;

and

light-converging point position control means for regulating a position of the light-

converging point of the first laser light within the object by detecting reflected light of the second

laser light reflected by the laser light irradiation surface.

Claim 2 (Original): A laser processing apparatus according to claim 1, wherein the laser

light irradiation surface is a surface of the object on the condenser lens side; and

wherein the light-converging point position control means regulates the position of light-

converging point of the first laser light such that the position of light-converging point of the first

laser light is at a predetermined depth from the surface on the condenser lens side.

Claim 3 (Currently amended): A laser processing apparatus according to claim 1, or 2,

wherein the light-converging point position control means regulates the position of light-

converging point of the first laser light within the object by changing a distance between the

condenser lens and the object.

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Claim 4 (Currently amended): A laser processing apparatus according to one of claims 1

to 3 claim 1, wherein a filter transmitting the reflected light of the second laser light but blocking

reflected light of the first laser light reflected by the laser light irradiation surface is provided on

the optical path of the reflected light of the second laser light.

Claim 5 (Original): A laser processing apparatus for irradiating an object to be processed

with first laser light so as to process the object, the apparatus comprising:

a condenser lens for converging the first laser light and second laser light for measuring a

displacement of a laser light irradiation surface of the object onto the object on the same axis;

and

light-converging point position control means for regulating a position of a light-

converging point of the first laser light with respect to the object by detecting reflected light of

the second laser light reflected by the laser light irradiation surface.

Claim 6 (Original): A laser processing method of irradiating a wafer-like object to be

processed with first laser light while locating a light-converging point within the object so as to

form a modified region by multiphoton absorption within the object; the method comprising the

steps of:

converging the first laser light and second laser light for measuring a displacement of a

laser light irradiation surface of the object onto the object on the same axis; and

regulating a position of the light-converging point of the first laser light within the object

by detecting reflected light of the second laser light reflected by the laser light irradiation

surface.

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Claim 7 (Original): A laser processing method of irradiating an object to be processed with first laser light so as to process the object; the method comprising the steps of:

converging the first laser light and second laser light for measuring a displacement of a laser light irradiation surface of the object onto the object on the same axis; and

regulating a position of the light-converging point of the first laser light with respect to the object by detecting reflected light of the second laser light reflected by the laser light irradiation surface.

Claim 8 (New): A laser processing apparatus for irradiating a wafer-like object to be processed with first laser light while locating a light-converging point within the object so as to form a modified region within the object, the apparatus comprising:

a condenser lens for converging the first laser light and second laser light for measuring a displacement of a laser light irradiation surface of the object onto the object on the same axis; and

light-converging point position control means for regulating a position of the light-converging point of the first laser light within the object by detecting reflected light of the second laser light reflected by the laser light irradiation surface.

Claim 9 (New): A laser processing method of irradiating a wafer-like object to be processed with first laser light while locating a light-converging point within the object so as to form a modified region within the object, the method comprising the steps of:

converging the first laser light and second laser light for measuring a displacement of a

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laser light irradiation surface of the object onto the object on the same axis; and regulating a position of the light-converging point of the first laser light within the object by detecting reflected light of the second laser light reflected by the laser light irradiation surface.